

HEXFET® POWER MOSFET

IRFN350

N-CHANNEL

400 Volt, 0.315Ω HEXFET

HEXFET technology is the key to International Rectifier's advanced line of power MOSFET transistors. The efficient geometry achieves very low on-state resistance combined with high transconductance.

HEXFET transistors also feature all of the well-establish advantages of MOSFETs, such as voltage control, very fast switching, ease of paralleling and electrical parameter temperature stability. They are well-suited for applications such as switching power supplies, motor controls, inverters, choppers, audio amplifiers, and high energy pulse circuits.

The Surface Mount Device (SMD-1) package represents another step in the continual evolution of surface mount technology. The SMD-1 will give designers the extra flexibility they need to increase circuit board density. International Rectifier has engineered the SMD-1 package to meet the specific needs of the power market by increasing the size of the termination pads, thereby enhancing thermal and electrical performance.

Product Summary

Part Number	BVDSS	RDS(on)	lb
IRFN350	400V	0.315Ω	14A

Features:

- Avalanche Energy Rating
- Dynamic dv/dt Rating
- Simple Drive Requirements
- Ease of Paralleling
- Hermetically Sealed
- Surface Mount
- Light-weight

Absolute Maximum Ratings

	Parameter	IRFN350	Units	
ID @ VGS = 10V, TC = 25°C	Continuous Drain Current	14		
$I_D @ V_{GS} = 10V, T_C = 100^{\circ}C$	Continuous Drain Current	9	A	
IDM	Pulsed Drain Current ①	56		
P _D @ T _C = 25°C	Max. Power Dissipation	150	W	
	Linear Derating Factor	1.2	W/K ®	
VGS	Gate-to-Source Voltage	±20	V	
EAS	Single Pulse Avalanche Energy ②	700	mJ	
IAR	Avalanche Current ①	14	А	
EAR	Repetitive Avalanche Energy ①	15	mJ	
dv/dt	Peak Diode Recovery dv/dt ®	4.0	V/ns	
TJ	Operating Junction	-55 to 150		
TSTG	Storage Temperature Range		°C	
	Package Mounting Surface Temperature	emperature 300 (for 5 seconds)		
	Weight	2.6 (typical)	g	

Electrical Characteristics @ Tj = 25°C (Unless Otherwise Specified)

	Parameter	Min.	Тур.	Max.	Units	Test Conditions
BVDSS	Drain-to-Source Breakdown Voltage	400	_	_	V	VGS = 0V, ID = 1.0mA
ΔΒVDSS/ΔΤJ	Temperature Coefficient of Breakdown Voltage	_	0.46	_	V/°C	Reference to 25°C, ID = 1.0mA
RDS(on)	Static Drain-to-Source	_	_	0.315		VGS = 10V, ID = 9A ④
	On-State Resistance	_	_	0.415	Ω	VGS = 10V, ID = 14A
VGS(th)	Gate Threshold Voltage	2.0	_	4.0	V	V _{DS} = V _{GS} , I _D = 250μA
gfs	Forward Transconductance	6.0	_	_	S (7)	VDS > 15V, IDS = 9A 4
IDSS	Zero Gate Voltage Drain Current	1	_	25		$V_{DS} = 0.8 \text{ x Max Rating}, V_{GS} = 0V$
		_	_	250	μΑ	V _{DS} = 0.8 x Max Rating
						VGS = 0V, TJ = 125°C
IGSS	Gate-to-Source Leakage Forward	_	_	100	nA	VGS = 20V
IGSS	Gate-to-Source Leakage Reverse		_	-100	117 \	VGS = -20V
Qg	Total Gate Charge	52	_	110		VGS = 10V, ID = 14A
Qgs	Gate-to-Source Charge	5.0	_	18	nC	VDS = Max. Rating x 0.5
Qgd	Gate-to-Drain ("Miller") Charge	25	_	65		see figures 6 and 13
td(on)	Turn-On Delay Time		_	35		VDD = 200V, ID = 14A,
tr	Rise Time		_	190	ns	$R_G = 2.35\Omega$, $VGS = 10V$
td(off)	Turn-Off Delay Time	_	_	170	115	
tf	FallTime	_	_	130		see figure 10
LD	Internal Drain Inductance	_	2.0	_	nH	Measured from the drain lead, 6mm (0.25 in.) from package to center of die. Modified MOSFET symbol showing the internal inductances.
LS	Internal Source Inductance	_	6.5	_	11111	Measured from the source lead, 6mm (0.25 in.) from package to source bonding pad.
C _{iss}	Input Capacitance		2600	_		VGS = 0V, VDS = 25V
Coss	Output Capacitance		680	_	pF	f = 1.0 MHz
C _{rss}	Reverse Transfer Capacitance		250	_		see figure 5

Source-Drain Diode Ratings and Characteristics

	Parameter		Min.	Тур.	Max.	Units	Test Conditions
Is	Continuous Source Current (Body Diode)		_	_	14	. A	Modified MOSFET symbol showing the
ISM	ISM Pulse Source Current (Body Diode) ①		_	_	56	, ,	integral reverse p-n junction rectifier.
VSD	Diode Forward Voltage		_	_	1.7	V	Tj = 25°C, IS = 14A, VGS = 0V ④
t _{rr}	Reverse Recovery Time		_	_	1200	ns	Tj = 25°C, IF = 14A, di/dt ≤ 100A/μs
QRR	Reverse Recovery Charge		_		11	μC	V _{DD} ≤ 50V ④
ton	Forward Turn-On Time	Intrinsic turn-on time is negligible. Turn-on speed is substantially controlled by $LS + LD$.					

Thermal Resistance

	Parameter	Min.	Тур.	Max.	Units	Test Conditions
R _{th} JC	Junction-to-Case	_	_	0.83		
R _{th} J-PCB	Junction-to-PC Board	_	TBD	_	K/W	Soldered to a copper clad PC board

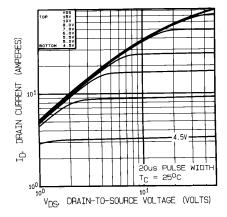


Fig. 1 — Typical Output Characteristics $T_C = 25^{\circ}C$

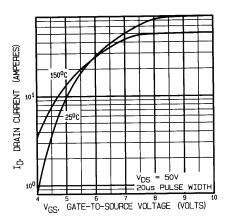


Fig. 3 — Typical Transfer Characteristics

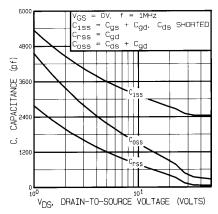


Fig. 5 — Typical Capacitance Vs. Drain-to-Source Voltage

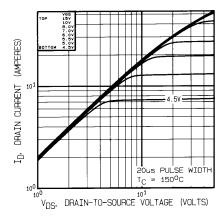


Fig. 2 — Typical Output Characteristics $T_C = 150$ °C

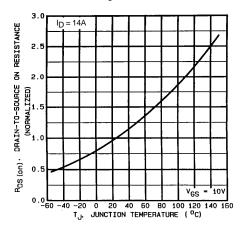


Fig. 4 — Normalized On-Resistance Vs.Temperature

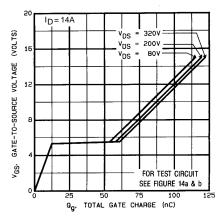


Fig. 6 — Typical Gate Charge Vs. Gate-to-Source Voltage

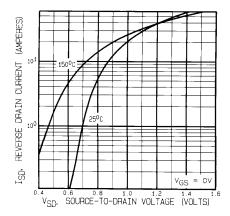


Fig. 7 — Typical Source-to-Drain Diode Forward Voltage

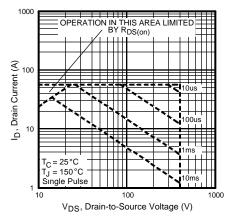


Fig. 8 — Maximum Safe Operating Area

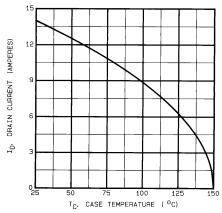


Fig. 9 — Maximum Drain Current Vs. Case Temperature

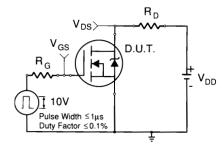


Fig. 10a — Switching Time Test Circuit

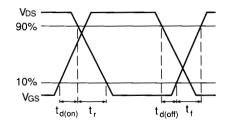


Fig. 10b — Switching Time Waveforms

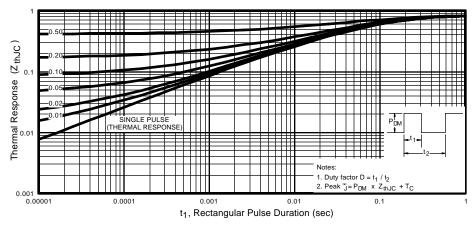


Fig. 11 — Maximum Effective Transient Thermal Impedance, Junction-to-Case Vs. Pulse Duration

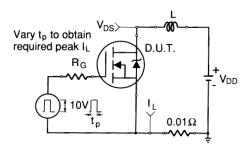


Fig. 12a — Unclamped Inductive Test Circuit

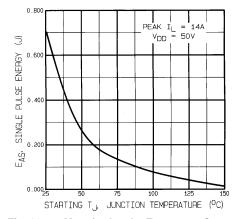


Fig. 12c — Max. Avalanche Energy vs. Current

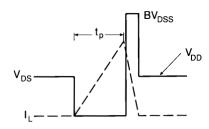


Fig. 12b — Unclamped Inductive Waveforms

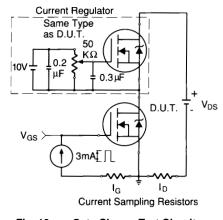


Fig. 13a — Gate Charge Test Circuit

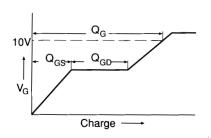
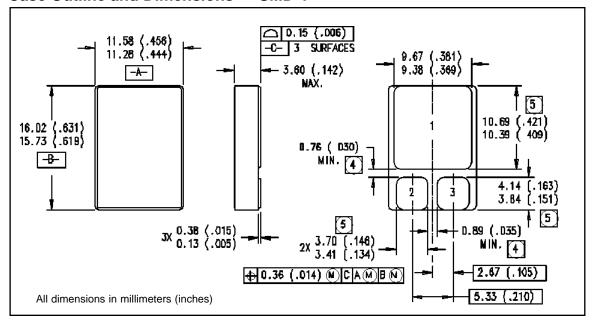


Fig. 13b — Basic Gate Charge Waveform

- Repetitive Rating; Pulse width limited by maximum junction temperature. (see figure 11)
- ② @ $V_{DD} = 50V$, Starting $T_J = 25^{\circ}C$, $E_{AS} = [0.5 * L * (I_L^2) * [BV_{DSS}/(BV_{DSS}-V_{DD})]$ $Peak I_L = 14A$, $V_{GS} = 10V$, $25 \le R_G \le 200\Omega$
- ③ ISD ≤ 14A, di/dt ≤ 145A/ μ s, VDD ≤ BVDSS, T,I ≤ 150°C
- ④ Pulse width ≤ 300 µs; Duty Cycle ≤ 2%
- ⑤ K/W = °C/W W/K = W/°C

Case Outline and Dimensions — SMD-1



International TOR Rectifier

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